

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Group Art Unit: To Be Assigned  
Examiner: To Be Assigned

In re DIVISIONAL PATENT APPLICATION OF

Applicant(s)	:	Fumio EGUCHI	)	
			)	
Appln. No.	:	To Be Assigned	)	
			)	
Filed	:	Herewith	)	<b>INFORMATION</b>
			)	<b>DISCLOSURE</b>
For	:	SEMICONDUCTOR DEVICE HAVING	)	<b>STATEMENT</b>
		PLL-CIRCUIT	)	
			)	
Atty. Dkt.	:	IIZ 131 D1	)	
			)	

Mail Stop: Patent Application  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

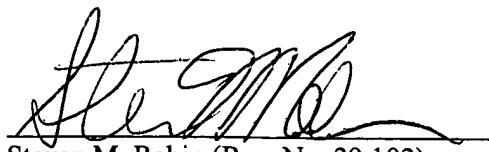
Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(1).

The Examiner is respectfully requested to consult related copending application serial number 10/304,675, filed on November 27, 2002, for which priority under 35 U.S.C. §120 has been relied upon, for copies of the documents listed on the attached PTO-1449 form, which have been previously submitted therein (37 C.F.R. §1.98(d)). A copy of one PTO-892 Form listing references cited by the Examiner in the parent application is likewise attached.

Since this Information Disclosure Statement is being filed with the application, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to the document submitted. Consideration of the previously submitted documents is respectfully requested.

Respectfully submitted,

  
Steven M. Rabin (Reg. No. 29,102)  
Customer No. 23995

FEE ENCLOSED: \$770.00  
Pl as charg any further  
f et ur Deposit Account  
No. 18-0002

December 31, 2003  
Date

<b>FORM PTO-1449</b> <b>INFORMATION DISCLOSURE STATEMENT</b>		Atty Docket	Application No.				
		IIZ 131	10/304,675				
		Applicant	Fumio EGUCHI				
		Filing Date	Group Unit November 27, 2002 2818				
<b>U.S. PATENT DOCUMENTS</b>							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
<b>FOREIGN PATENT DOCUMENTS</b>							
		Document Number	Date	Country	Class	Sub-Class	Trans-lation
	AL	10/288,653	10/27/98	Japan			Abstract
	AM	2000-035463	02/02/00	Japan			Abstract
	AN	2000-314767	11/14/00	Japan			Abstract
	AO						
<b>OTHER (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AP						
	AQ						
	AR						
Examiner					Date Considered		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							

**Notice of References Cited**

Application/Control No.

10/304,675

Applicant(s)/Patent Under

Reexamination

EGUCHI, FUMIO

Examiner

ANH PHUNG

Art Unit

2824

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,400,625	06-2002	Arimoto et al.	365/201
*	B	US-6,078,533	06-2000	Lee, Terry R.	365/194
*	C	US-5,946,244	08-1999	Manning, Troy A.	365/194
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.